



# Power MOSFETS

## DATASHEET

**LM20A95PGI3A**

P-Channel  
Enhancement Mode MOSFET

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Quality Management Systems  
ISO 9001:2015 Certificate

## P-Channel Enhancement Mode MOSFET

### Pin Description

SOT-23 (TOP view)	Symbol	Symbol	P-Channel	Unit
		$V_{DSS}$	-20	V
		$R_{DS(ON)-Max}$	205	$\text{m}\Omega$
		$ID$	-1.8	A

### Feature

- Reliable and Rugged
- ROHS Compliant

### Applications

- Load Switches
- BLDC Motor

### Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM20A95PGI3A	SOT-23	Tape & Reel	3000 / Tape & Reel	20A95 □□□□□□

Note : □□□□□□ = Lot Code

### Absolute Maximum Ratings ( $T_J=25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	P-Channel	Unit
$V_{DSS}$	Drain-Source Voltage	-20	V
$V_{GSS}$	Gate-Source Voltage	$\pm 8$	
$T_J$	Maximum Junction Temperature	150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$I_{DM}$	Pulse Drain Current Tested	$T_c=25^\circ\text{C}$	A
$I_D$	Continuous Drain Current	$T_c=25^\circ\text{C}$	$-1.8^{\textcircled{1}}$
		$T_c=70^\circ\text{C}$	-1.4
$P_D$	Maximum Power Dissipation	$T_c=25^\circ\text{C}$	W
		$T_c=70^\circ\text{C}$	0.6
$I_{AS}^{\textcircled{2}}$	Avalanche Current, Single pulse	$L=0.1\text{mH}$	A
		$L=0.5\text{mH}$	-4
$E_{AS}^{\textcircled{2}}$	Avalanche Energy, Single pulse	$L=0.1\text{mH}$	mJ
		$L=0.5\text{mH}$	0.8

### Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{JA}^{\textcircled{3}}$	Thermal Resistance-Junction to Ambient	Steady State	$140\text{ }^\circ\text{C/W}$

Note ① : Max. current is limited by junction temperature

Note ② : UIS tested and pulse width are limited by maximum junction temperature  $150^\circ\text{C}$

Note ③ : Surface Mounted on 1in<sup>2</sup> FR-4 board with 1oz.

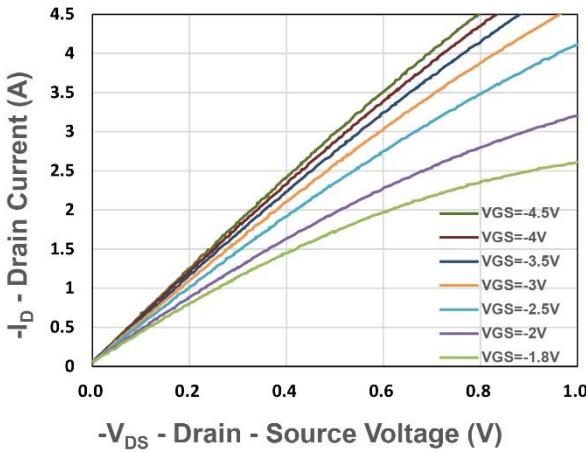
P-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics</b>						
$\mathbf{BV_{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_{DS}=-250\mu\text{A}$	-20	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-16\text{V}, V_{GS}=0\text{V}$	-	-	-1	$\mu\text{A}$
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=-250\mu\text{A}$	-0.4	-0.6	-1	V
$I_{GSS}$	Gate Leakage Current	$V_{GS}=\pm 8\text{V}, V_{DS}=0\text{V}$	-	-	$\pm 100$	$\text{nA}$
$R_{DS(\text{ON})}^{\text{(4)}}$	Drain-Source On-state Resistance	$V_{GS}=-4.5\text{V}, I_{DS}=-2\text{A}$	-	170	205	$\text{m}\Omega$
		$V_{GS}=-2.5\text{V}, I_{DS}=-1.5\text{A}$		210	300	
		$V_{GS}=-1.8\text{V}, I_{DS}=-0.5\text{A}$	-	265	450	
$g_{fs}$	Forward Transconductance	$V_{DS}=-5\text{V}, I_{DS}=-1.6\text{A}$	-	3.5	-	S
<b>Dynamic Characteristics <sup>(5)</sup></b>						
$R_G$	Gate Resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V},$ $\text{Freq.}=1\text{MHz}$	-	54	-	$\Omega$
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V},$ $V_{DS}=-10\text{V},$ $\text{Freq.}=1\text{MHz}$	-	191	-	$\text{pF}$
$C_{oss}$	Output Capacitance		-	29	-	
$C_{rss}$	Reverse Transfer Capacitance		-	3	-	
$t_{d(\text{ON})}$	Turn-on Delay Time	$V_{GS}=-4.5\text{V}, V_{DS}=-10\text{V},$ $I_D=-1\text{A}, R_{\text{GEN}}=1\Omega$	-	3	-	$\text{nS}$
$t_r$	Turn-on Rise Time		-	24	-	
$t_{d(\text{OFF})}$	Turn-off Delay Time		-	27	-	
$t_f$	Turn-off Fall Time		-	97	-	
$Q_g$	Total Gate Charge	$V_{GS}=-2.5\text{V}, V_{DS}=-10\text{V}$ $I_D=-2\text{A}$	-	1.1	-	
$Q_g$	Total Gate Charge	$V_{GS}=-4.5\text{V}, V_{DS}=-10\text{V},$ $I_D=-2\text{A}$	-	1.9	-	
$Q_{gs}$	Gate-Source Charge		-	0.42	-	
$Q_{gd}$	Gate-Drain Charge		-	0.32	-	
<b>Source-Drain Characteristics</b>						
$V_{SD}^{\text{(4)}}$	Diode Forward Voltage	$I_{SD}=-1.6\text{A}, V_{GS}=0\text{V}$	-	-0.8	-1.1	V
$t_{rr}$	Reverse Recovery Time	$I_F=-1\text{A}, V_R=-15\text{V}$	-	4.7	-	$\text{nS}$
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt=100\text{A}/\mu\text{s}$	-	0.9	-	$\text{nC}$

Note ④ : Pulse test (pulse width $\leq 300\text{us}$ , duty cycle $\leq 2\%$ ).

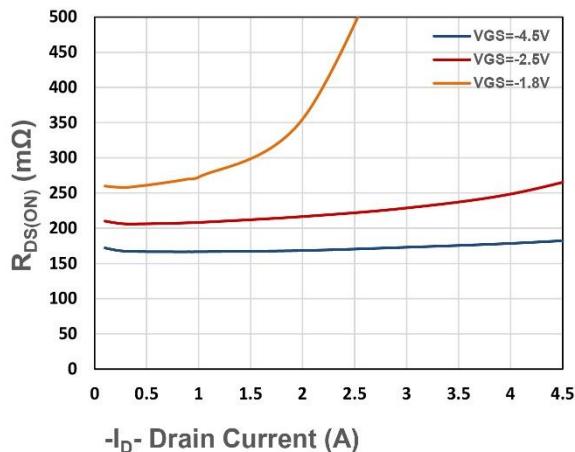
Note ⑤ : Guaranteed by design, not subject to production testing.

## P-Channel Typical Characteristics



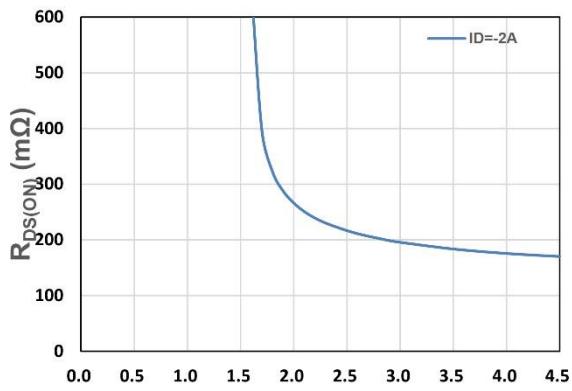
$-V_{DS}$  - Drain - Source Voltage (V)

Figure 1. Output Characteristics



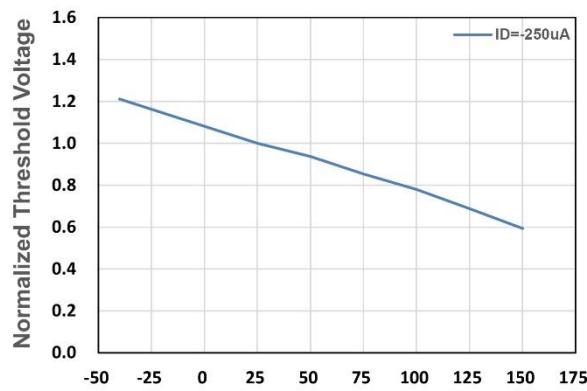
$-I_D$  - Drain Current (A)

Figure 2. On-Resistance vs. ID



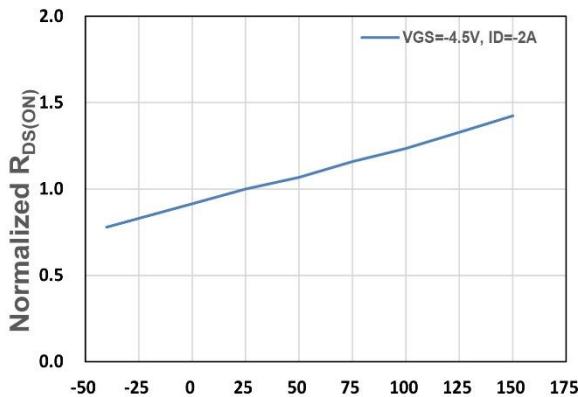
$-V_{GS}$  - Gate - Source Voltage (V)

Figure 3. On-Resistance vs. VGS



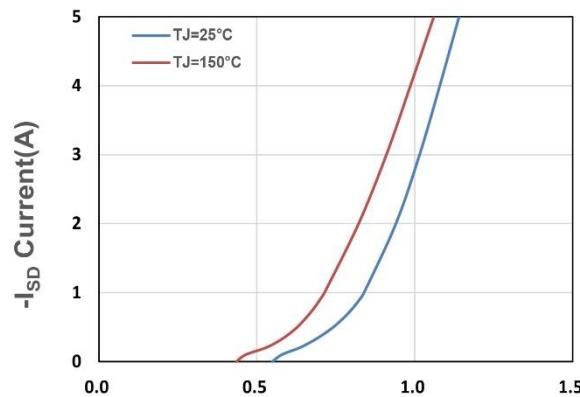
$T_j$ , Junction Temperature( $^\circ C$ )

Figure 4. Gate Threshold Voltage



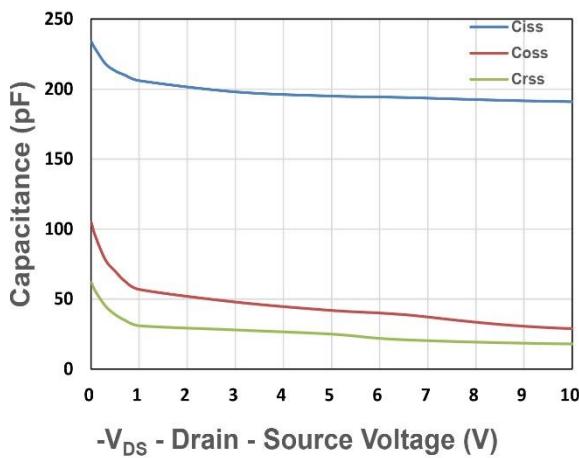
$T_j$  , Junction Temperature( $^\circ C$ )

Figure 5. Drain-Source On Resistance



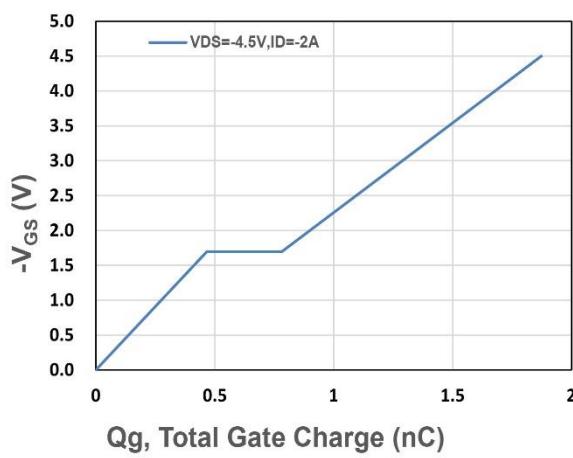
$-V_{SD}$ , Source-Drain Voltage(V)

Figure 6. Source-Drain Diode Forward



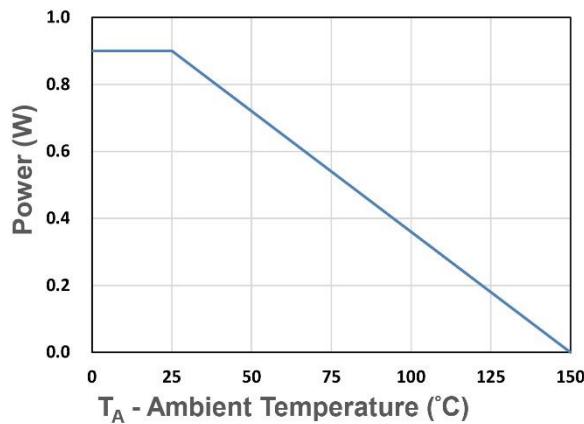
-V<sub>DS</sub> - Drain - Source Voltage (V)

Figure 7. Capacitance



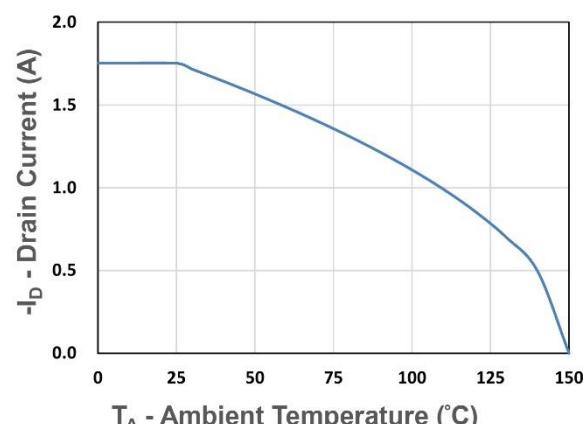
-V<sub>GS</sub> (V)

Q<sub>g</sub>, Total Gate Charge (nC)



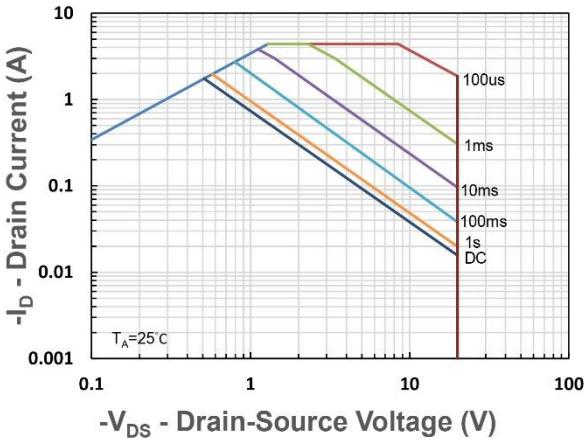
T<sub>A</sub> - Ambient Temperature (°C)

Figure 9. Power Dissipation



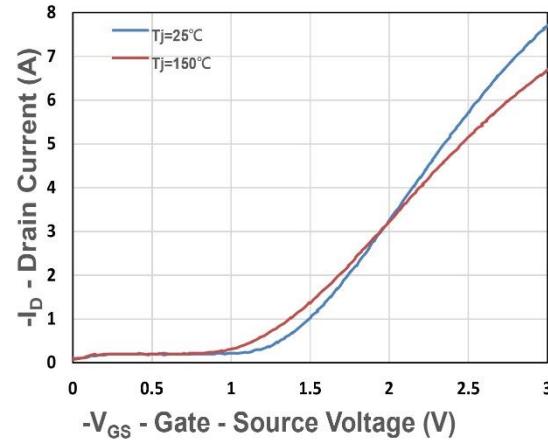
T<sub>A</sub> - Ambient Temperature (°C)

Figure 10. Drain Current



-V<sub>DS</sub> - Drain-Source Voltage (V)

Figure 11. Safe Operating Area



-V<sub>GS</sub> - Gate - Source Voltage (V)

Figure 12. Transfer Characteristics

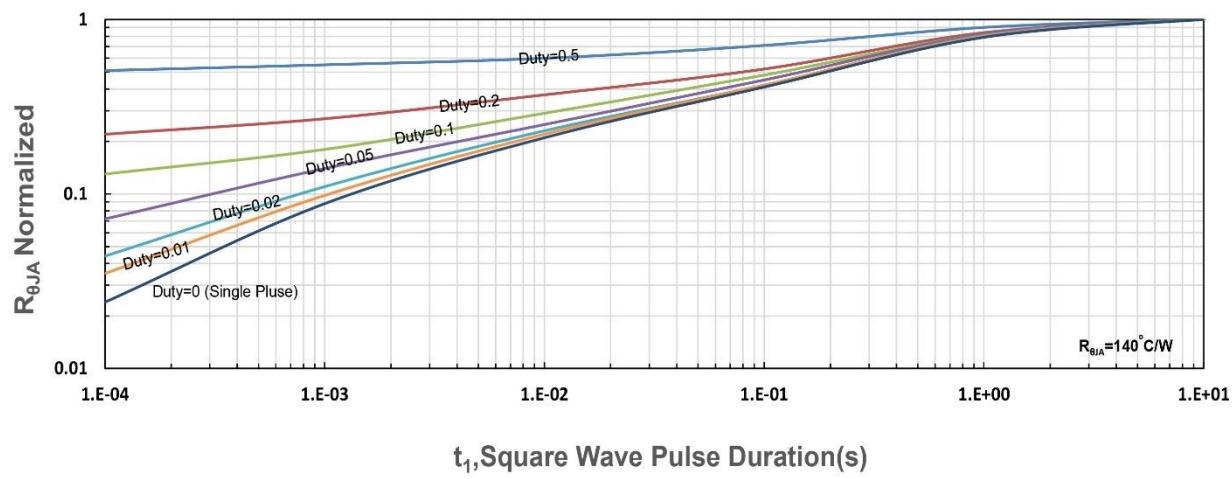


Figure 13.  $R_{\theta JA}$  Transient Thermal Impedance